

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/759,707 | Applicant(s)/Patent Under Reexamination LU ET AL. | |
| | Examiner Michael J Kyle | Art Unit 3676 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-5,190,391 | 03-1993 | Huong, Chin-fu | 403/96 |
| | B | US-6,154,925 | 12-2000 | Miura, Fumiaki | 16/338 |
| | C | US-6,256,838 | 07-2001 | Lu, Sheng-Nan | 16/342 |
| | D | US-6,453,509 | 09-2002 | Shin, Jong-Hwa | 16/340 |
| | E | US-6,421,878 | 07-2002 | Kaneko et al. | 16/330 |
| | F | US-6,539,582 | 04-2003 | Chae, Kwon-Byung | 16/340 |
| | G | US-6,666,422 | 12-2003 | Lu et al. | 248/291.1 |
| | H | US-6,779,234 | 08-2004 | Lu et al. | 16/340 |
| | I | US-6,813,813 | 11-2004 | Lu et al. | 16/342 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.